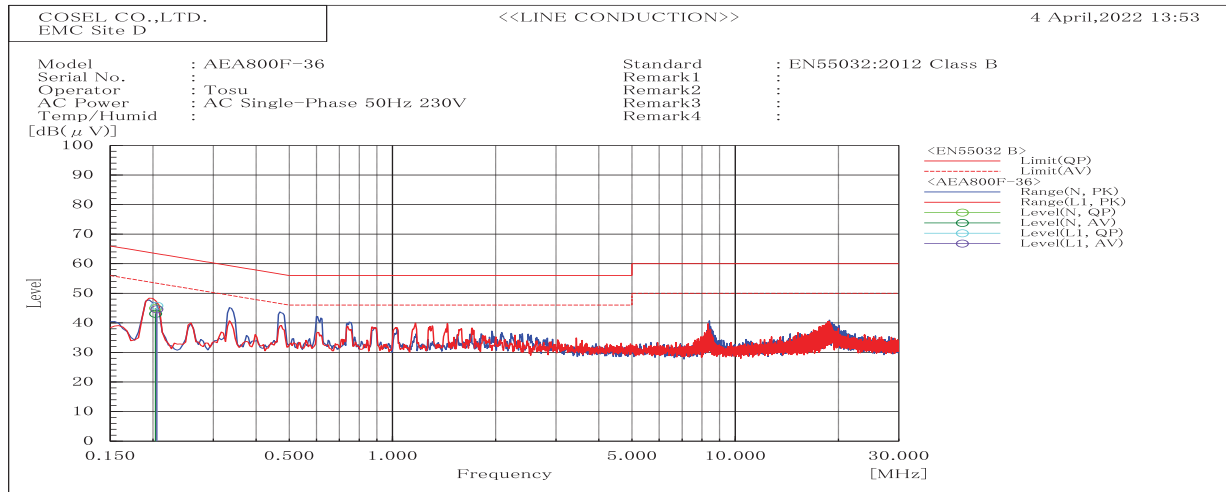
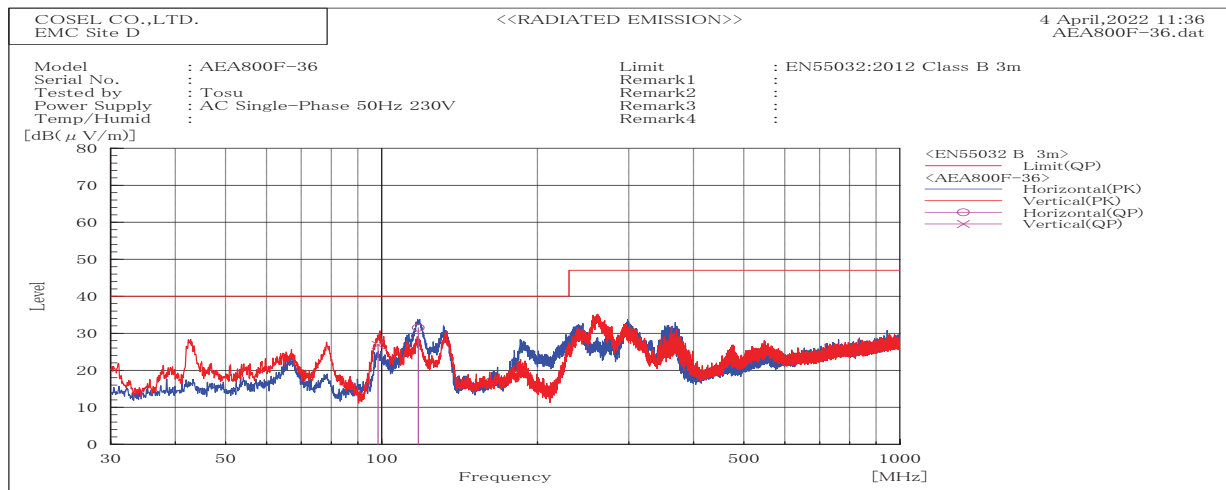


DATA SHEET		Date	05-Sep-22
Model	AEA800F-36	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	M.Tosu



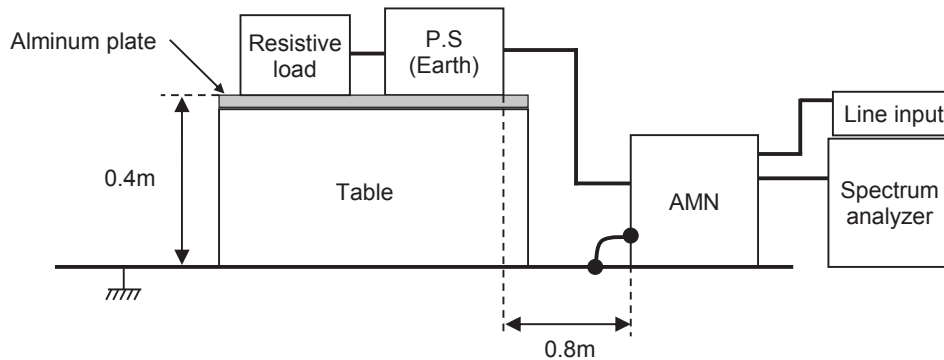
Frequency MHz	Line	Level dB(μ V)		Limit dB(μ V)		Margin dB		Pass/Fail	Remark
		QP	AV	QP	AV	QP	AV		
0.205	L1	45.8	44.6	63.4	53.4	17.6	8.8	Pass	
0.204	N	45	43.1	63.5	53.5	18.5	10.4	Pass	



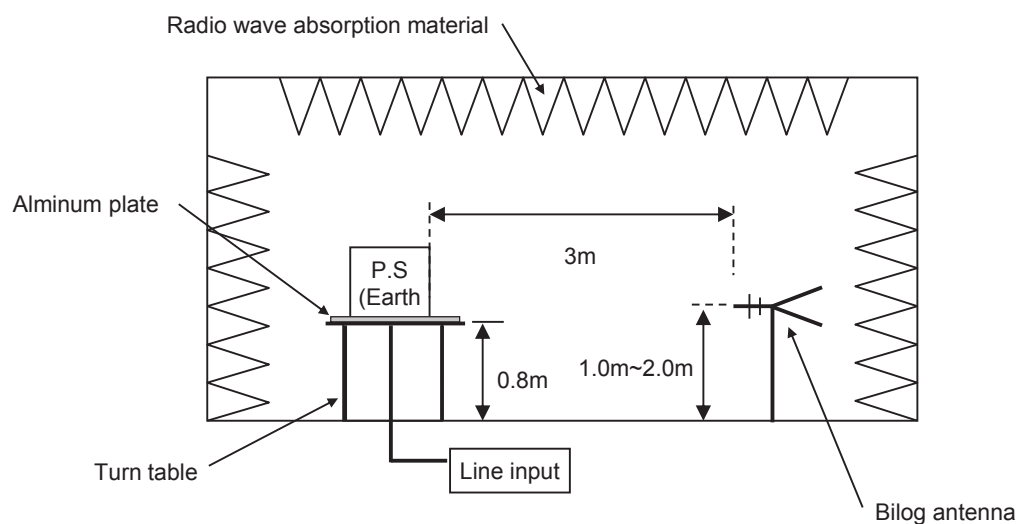
Frequency MHz	Polarization	Stability	Level dB(μ V/m)		Limit dB(μ V/m)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	QP						
98.46	V	Stable	26.8	40	13.2	Pass	105.6	298.8		
117.725	H	Stable	31.5	40	8.5	Pass	162.6	352.6		

DATA SHEET		Date	05-Sep-22
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	M.Tosu

1. Line conduction



2. Radiated emission



Conditions

Test : EMI
Model Name: AEA800F-36

Photographs of Test Set-Up

1.LINE CONDUCTION



2.RADIATED EMISSION

